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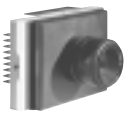


The Photometrics SenSys:3200E is a high-resolution digital imaging system that features a large field of view and 3.2 million pixels. This 12-bit, cooled CCD camera is designed for low-light scientific and industrial applications. The fine pitch of the pixels, 6.8 x 6.8 microns, is ideally matched to the resolution of optical microscopes. High resolution and small pixels allow imaging of very fine detail, yet the pixels can be easily binned to improve sensitivity. The CCD uses indium tin oxide (ITO) technology to raise quantum efficiency, particularly in the blue/green.

F E A T U R E S B E N E F I T S

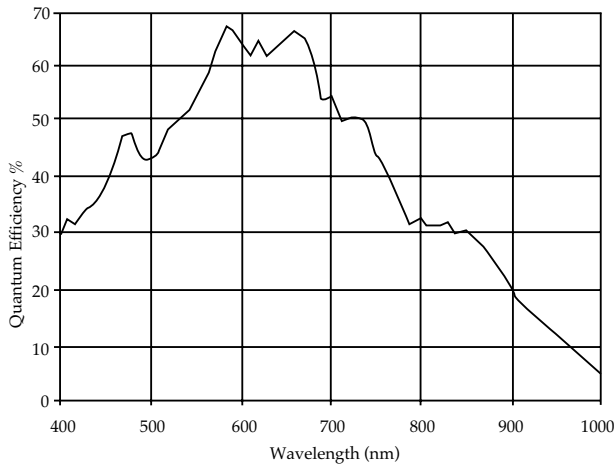
2184 x 1472 imaging array 6.8 x 6.8-µm pixels	Resolves fine detail Ideally matched to optical microscope
Scientific-grade CCD	Few defects and hot pixels
Single-window imaging path	Minimizes reflections and distortion
ITO transparent gates	Higher QE performance throughout visible spectrum
Three detection modes	Optimized for high sensitivity, high dynamic range, and high SNR
Flexible binning and readout	Increases light sensitivity while increasing the frame rate
12-bit digitization	Quantifies both bright and dim signals in the same image
Thermoelectric cooling	Long integration times for higher sensitivity
C-mount or F-mount with shutter	Selectable for the best optical path Easily attaches to standard lenses or optical equipment
Compact camera head	Easily fits your instrument
PCI interface	Works with PC, Macintosh, Linux®
Detailed test report	Proven performance characteristics





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S P E C I F I C A T I O N S

CCD image sensor	Kodak KAF3200E; scientific grade; MPP; Metachrome® II UV enhancement (optional)
CCD format	2184 x 1472 imaging pixels plus 46/37 serial pre/postscan pixels; 34/4 parallel pre/postscan rows; 6.8 x 6.8-µm pixels; 100% fill factor; 14.85 x 10.26-mm imaging area (optically centered)
Grades	Grade 1: ≤5 point defects, 0 cluster defects, 0 column defects; Grade 2: ≤10 point defects, ≤4 cluster defects, 0 column defects
User gains	Three detection modes or gains; user selectable; high sensitivity, high dynamic range, high SNR
Linear full well	90,000 e ⁻ @ 0.5x; 45,000 e ⁻ @ 1x; 10,000 e ⁻ @ 4x
Read noise	18 e ⁻ rms @ 0.5x; 15 e ⁻ rms @ 1x; 10 e ⁻ rms @ 4x
Nonlinearity	≤0.5%
Readout bits/speed	12 bits @ 1.4 MHz
Parallel shift rate	10.4 µsec/row
Serial discard rate	0.1 µsec/pixel
Frame readout	3.1 seconds for full frame
Dark current	1.5 e ⁻ /p/s with passive-air cooling (+10°C)
Operating environment	0 to 40°C ambient, 0 to 70% relative humidity

Note: Specifications are typical and subject to change.